




<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/695,197	FUJIYAMA ET AL.	
	Examiner	Art Unit	
	Nguyen T. Ha	2831	

ISSUE CLASSIFICATION													
ORIGINAL					CROSS REFERENCE(S)								
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
361		306.1			361	763	765	766	785				
INTERNATIONAL CLASSIFICATION					439	70	71	342					
H	0	1	G	4/228	174	252	255	262					
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Nguyen T. Ha 6/11/2005 (Assistant Examiner) (Date)		 <b>DEAN A. REICHARD</b> SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date)	Total Claims Allowed: 7	
 Donon Evans 6/13/05 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 64	O.G. Print Fig. 2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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